



SLP150N06G 60V N-Channel MOSFET

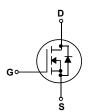
General Description

This Power MOSFET is produced using Msemitek's advanced Shielding Gate MOSFET technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as DC/DC converters and high efficiency switching for power management in portable and battery operated products.

Features

- 150A, 60V, $R_{DS(on)Typ}$ = 2.1m Ω @ V_{GS} = 10 V
- Very Low On-resistance R_{DS(ON)}
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability





Absolute Maximum Ratings

T_C = 25°C unless otherwise noted

Symbol	Parameter		SLP150N06G	Units
V_{DSS}	Drain-Source Voltage		60	V
	Drain Current - Continuous (T _C = 25°C)		150	Α
I_D	- Continuous (T _C = 100°C)		98	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	450	Α
V_{GSS}	Gate-Source Voltage		±20	V
EAS	Single Pulsed Avalanche Energy	(Note 2)	552	mJ
E _{AR}	Repetitive Avalanche Energy	(Note 1)	240	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
P_D	Power Dissipation (T _C = 25°C)		320	W
FD	- Derate above 25°C		2.56	W/°C
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	°C
	Maximum lead temperature for soldering purposes,			0-
T∟	1/8" from case for 5 seconds		300	°C

^{*} Drain current limited by maximum junction temperature.

Thermal Characteristics

Symbol	Parameter	SLP150N06G	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.39	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	°C/W

Package Marking

Symbol

Part Number	Top Marking	Package	Packing Method	MOQ	QTY
SLP150N06G	SLP150N06G	TO-220C	Tube	1000	5000

Electrical Characteristics

Parameter

T_C = 25°C unless otherwise noted

Test Conditions

Min

Typ

Max

Units

Off Ch	Off Characteristics							
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 uA	60			V		
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 60 V, V _{GS} = 0 V	-		1	uA		
		V _{DS} = 48 V, T _C = 150°C	-		10	uA		
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 20V, V _{DS} = 0 V	-		100	nΑ		
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA		

On Characteristics

$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_{D} = 250 \text{ uA}$	1.0	-	2.5	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 30 A		2.1	2.8	mΩ

Dynamic Characteristics

Ciss	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz	1	5460	 pF
Coss	Output Capacitance			2040	 pF
Crss	Reverse Transfer Capacitance	1 1.0 1911 12		5.5	 рF

Switching Characteristics

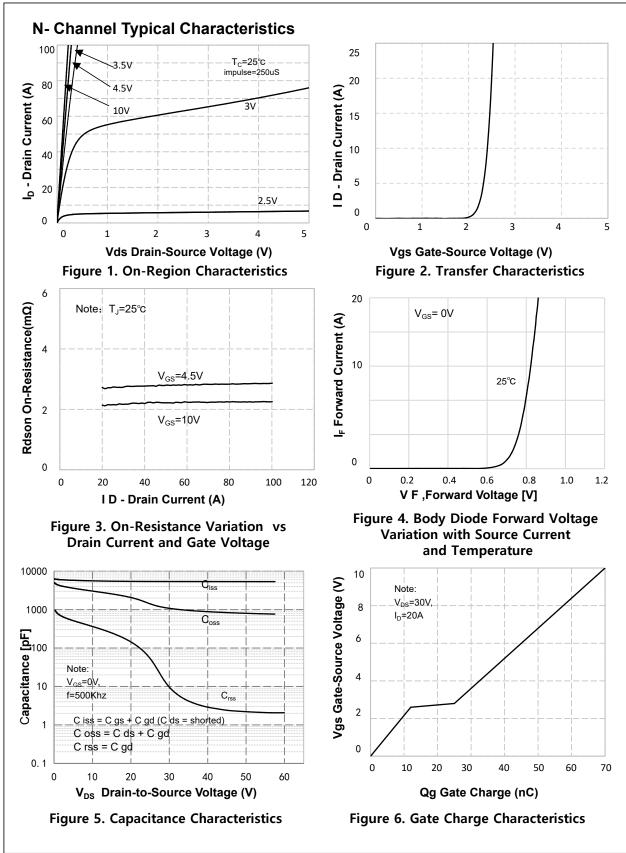
$t_{d(on)}$	Turn-On Delay Time			-	20	 ns
t _r	Turn-On Rise Time	$V_{DD} = 30 \text{ V}, I_D = 60 \text{ A},$		1	127	 ns
$t_{\sf d(off)}$	Turn-Off Delay Time	$R_G = 4.7 \Omega$	(Note 4, 5)	1	95	 ns
t _f	Turn-Off Fall Time		(11010 1, 0)	1	25	 ns
Q_g	Total Gate Charge	$V_{DS} = 30 \text{ V}, I_{D} = 30 \text{ A},$		1	70	 nC
Q_{gs}	Gate-Source Charge	V _{GS} = 10 V		1	21	 nC
Q_{gd}	Gate-Drain Charge		(Note 4, 5)	1	33	 nC

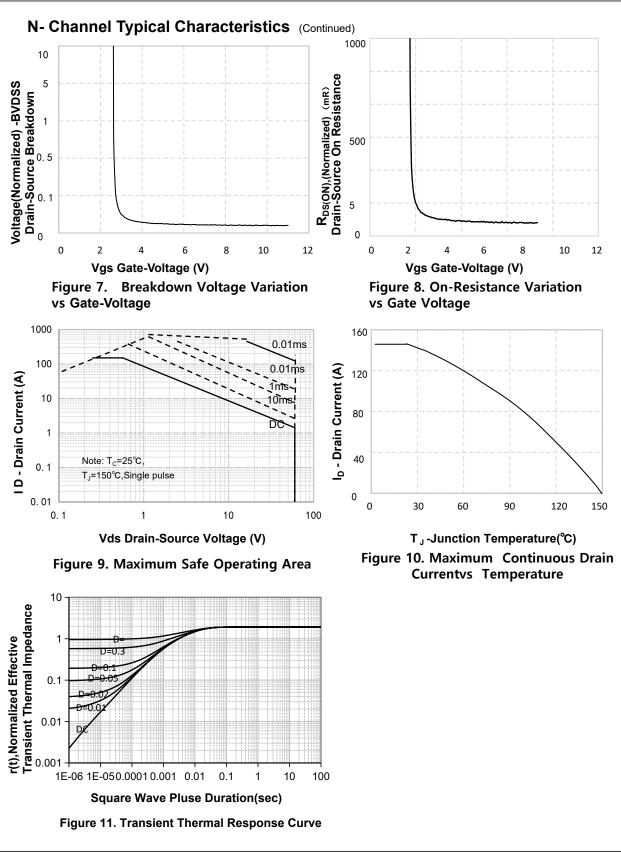
Drain-Source Diode Characteristics and Maximum Ratings

Is	Maximum Continuous Drain-Source Diode Forward Current		1	-	150	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		-	-	450	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 30 A	1	-	1.4	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_{S} = 30 \text{ A},$	-	63	-	ns
Qrr	Reverse Recovery Charge	dI _F / dt = 80 A/us (Note 4)		59		nC

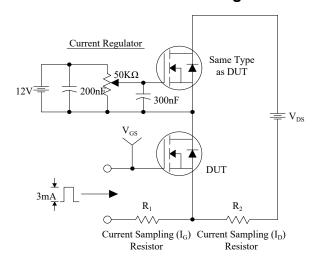
Notes:

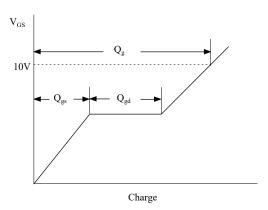
- 1. Repetitive Rating : Pulse width limited by maximum junction temperature
- 2. $I_{AS} = I_D$, $V_{DD} = 30V$, $R_G = 25\Omega$, Starting $T_J = 25$ °C
- 3. $l_{SD} \le l_D$, di/dt $\le 200 \text{A/us}$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}\text{C}$ 4. Pulse Test : Pulse width $\le 300 \text{us}$, Duty cycle $\le 2^{\circ}$
- 5. Essentially independent of operating temperature



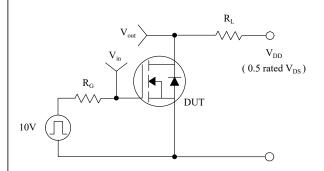


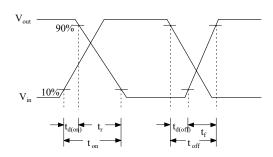
Gate Charge Test Circuit & Waveform



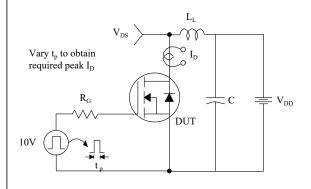


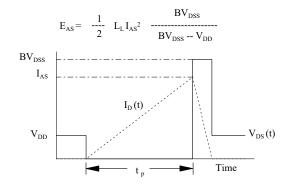
Resistive Switching Test Circuit & Waveforms



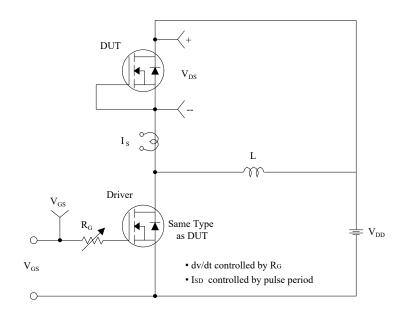


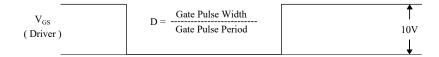
Unclamped Inductive Switching Test Circuit & Waveforms

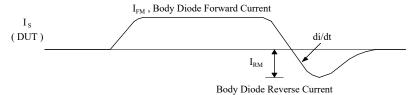


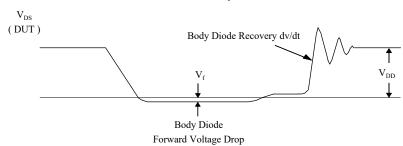


Peak Diode Recovery dv/dt Test Circuit & Waveforms

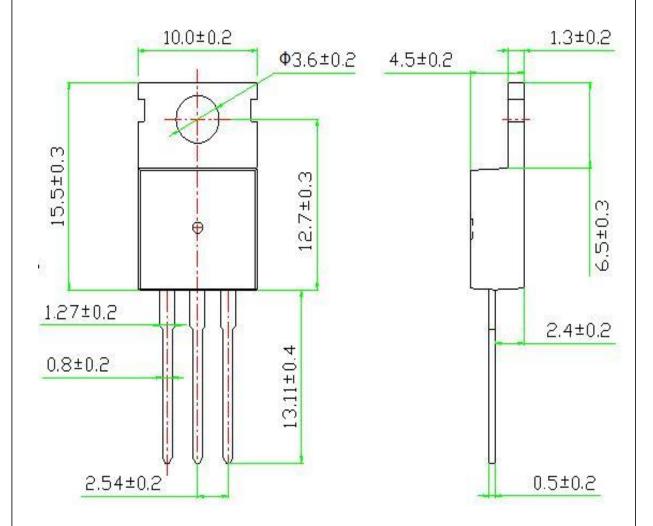








TO-220C OUTLINE



NOTE:

1The plastic package is not marked as smooth surfaceRa=0.1;Subglossy surfaceRa=0.8 2.Undeclared tolerance \pm 0.25,Unmarked filletRmax=0.25

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